University of Huddersfield Repository

Blunt, Liam and Elrawemi, Mohamed

Functional Modelling of Water Vapour Transmission through Surface Defects Using Surface Segmentation Analysis

Original Citation


This version is available at http://eprints.hud.ac.uk/23674/

The University Repository is a digital collection of the research output of the University, available on Open Access. Copyright and Moral Rights for the items on this site are retained by the individual author and/or other copyright owners. Users may access full items free of charge; copies of full text items generally can be reproduced, displayed or performed and given to third parties in any format or medium for personal research or study, educational or not-for-profit purposes without prior permission or charge, provided:

- The authors, title and full bibliographic details is credited in any copy;
- A hyperlink and/or URL is included for the original metadata page; and
- The content is not changed in any way.

For more information, including our policy and submission procedure, please contact the Repository Team at: E.mailbox@hud.ac.uk.

http://eprints.hud.ac.uk/
Functional Modelling of Water Vapour Transmission Through Surface Defects Using Surface Segmentation Analysis

L. Blunt and M. Elrawemi
1EPSRC Centre for Innovative Manufacturing in Advanced Metrology, University of Huddersfield, UK;

Background

Flexible Photovoltaic (PV) modules are manufactured using roll to roll (R2R) technology. These modules require a flexible barrier material to prevent water vapour ingress into the core material.

Thin-Film Flexible PV Modules

Flexible solar modules comprise four functional layer groupings. The main focus of the investigation in this work is the barrier layer, which is incorporated in the encapsulation layers. This layer is typically formed from a planarised Polyethylene Naphthalate (PEN) sheet with an amorphous Al2O3 barrier coating (≤ 40 nm thick).

R2R Al2O3 ALD Barrier Film

Thin layers of aluminum-oxide, of the order of a few tens of nanometers deposited via R2R atomic layer deposition (ALD) method, have been introduced to allow PV modules transparency and flexibility and to provide an effective barrier layer.

Research Challenges

Micro and nano scale defects existing in the PV barrier films degrades their performance over time due to water vapour ingress.

Experimental Work

Two representative Al2O3 ALD samples were processed by the Centre for Process Innovation Ltd (CPI). The samples have an 80 mm diameter area coated with a 40nm Al2O3 layer. The WVTRs of samples were carried out using an Isostatic Standard test method (MOCON®) at specified conditions of (38 °C and 90% RH) respectively.

Table 1. WVTR at 38°C and 90% RH

<table>
<thead>
<tr>
<th>Sample No</th>
<th>Water vapor transmission rate (g/m²/24 hrs.)</th>
<th>Stabilisation time (day)</th>
</tr>
</thead>
<tbody>
<tr>
<td>1</td>
<td>4.1×10⁻³</td>
<td>5</td>
</tr>
<tr>
<td>2</td>
<td>2.0×10⁻³</td>
<td>5</td>
</tr>
</tbody>
</table>

Mathematical Model

The basic assumption of the model is that, the combined film of thickness L has a transparent flexible barrier coating of (Al2O3) with a single circular hole (defect), and that it is exposed to permeant water vapour from the lower side. This orientation is consistent with that used in a MOCON® test.

\[ P_2 = D \times S = \frac{q_{L}D}{\nabla} \left( \text{cm}^2 \text{ cm} \right) \]  \hspace{1cm} (2)

\[ Q = \frac{q_{L}D}{L} \] \hspace{1cm} (3)

\[ \text{WVTR} = \frac{Q}{A} \left( \text{m}^2 \text{day} \right) \] \hspace{1cm} (4)

Surface Characterisation and Analysis

Quantitative surface measurement was carried out using optical interferometry (CCI-3000 Taylor Hobson Ltd.) and the topography was characterised using areal parameters (ISO25178-2, 2012). Segmentation analysis was carried out on the data (700 data files) in order to extract and count the number of significant defects present on the substrates.

Results

The results seem to show that for the barrier coating a small number of large defects dominates the WVTR, and thus these defects should be the focus of any detection system.

Conclusion

The segmentation analysis method and the theoretical model results, both indicate that the major contributing factor for determining the WVTR is the total number of larger defects, where the sample with higher density of defects > 3 μm (lateral diameter) exhibit inferior barrier properties. Therefore, the critical spatial resolution required for defect detection need not be less than 3 μm, as any defect that has less than this lateral size seems to have a much lower effect on the barrier properties.

Acknowledgement

To EPSRC via EU FP7 programme for NanoMend project NMP4 LA-2011-280581 and Libyan Cultural Attache in London

References

2. ISO 25178-2:2012(E), Terms, definitions and surface texture parameters. Switzerland. 1-47.